

EMC Test Report

Report No.: AGC12440230902EE01

PRODUCT DESIGNATION : Bamboo penholder with calendar

BRAND NAME : N/A

MODEL NAME : M06289

APPLICANT : Mid Ocean Brands B.V.

DATE OF ISSUE : Nov. 03, 2023

EN IEC 55014-1:2021 STANDARD(S)

EN IEC 55014-2:2021

REPORT VERSION : V1.0

> Attestation of Global (Shenzhen) Co., Ltd



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REPORT REVISE RECORD

Report Version	Revise Time	Issued Date	Valid Version	Notes
V1.0	1	Nov. 03, 2023	Valid	Initial release

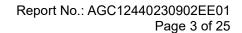




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1. VERIFICATION OF CONFORMITY

Applicant	Mid Ocean Brands B.V.
Address	7/F., King Tower, 111King Lam Street, Cheung ShaWan, Kowloon, HongKong.
Manufacturer	Mid Ocean Brands B.V.
Address	7/F., King Tower, 111King Lam Street, Cheung ShaWan, Kowloon, HongKong.
Factory	Mid Ocean Brands B.V.
Address	7/F., King Tower, 111King Lam Street, Cheung ShaWan, Kowloon, HongKong.
Product Designation Bamboo penholder with calendar	
Brand Name	N/A
Test Model	MO6289
Date of receipt of test item	Sep. 25, 2023
Date of test	Sep. 25, 2023 - Nov. 02, 2023
Deviation	No any deviation from the test method.
Condition of Test Sample	Normal
Test Result	Pass

The above equipment was tested by Attestation of Global Compliance (Shenzhen) Co., Ltd. for compliance with the requirements set forth in the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

The test results of this report relate only to the tested sample identified in this report.

Prepared By	Sty Zhou	
•	Sky Zhou (Project Engineer)	Nov. 03, 2023
Reviewed By	Calin Lin	
	Calvin Liu (Reviewer)	Nov. 03, 2023
Approved By	Max Zhang	
	Max Zhang (Authorized Officer)	Nov. 03, 2023



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2. SYSTEM DESCRIPTION

	TEST MODE DESCRIPTION				
NO. TEST MODE DESCRIPTION WORST					
1	Normal operation mode				

3. MEASUREMENT UNCERTAINTY

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in measurement" (GUM) published by ISO.

- Uncertainty of Conducted Emission, Uc = ±2.9dB
- Uncertainty of Radiated Emission, Uc = ±3.8 dB



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4. PRODUCT INFORMATION

Housing Type	Wood,plastics and glass
Classification of apparatus	Category III
Power Supply	DC 3V by battery
Hardware Version	N/A
Software Version	N/A

I/O Port Information (☐ Applicable ☐ Not Applicable)

I/O Port of EUT					
I/O Port Type Number Cable Description Tested With					



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5. SUPPORT EQUIPMENT

Device Type	Manufacturer	Model Name	Serial No.	Data Cable	Power Cable



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6. TEST FACILITY

Site	Attestation of Global Compliance (Shenzhen) Co., Ltd
Location	1-2/F, Building 19, Junfeng Industrial Park, Chongqing Road, Heping Community, Fuhai Street, Bao 'an District, Shenzhen, Guangdong, China

7. TEST EQUIPMENT LIST

TEST EQUIPMENT OF RADIATED EMISSION TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Test Receiver	R&S	ESCI	10096	Feb. 18, 2023	Feb. 17, 2024
Antenna	SCHWARZBECK	VULB9168	494	Jan. 05, 2023	Jan. 04, 2025
Test software	FARA	EZ-EMC(Ver.RA-03A)	N/A	N/A	N/A

TEST EQUIPMENT OF ESD TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
ESD Simulator	Schaffner	NSG 438	782	Dec. 30, 2022	Dec. 29, 2023

TEST EQUIPMENT OF RS IMMUNITY TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Signal Generator	R&S	E4421B	MY43351603	Feb. 17, 2023	Feb. 16, 2024
Power Sensor	R&S	URV5-Z4	100124	Mar. 24, 2023	Mar. 23, 2025
Power Meter	R&S	NRVD	8323781027	Mar. 24, 2023	Mar. 23, 2025
Power Amplifier	KALMUS	7100LC	04-02/17-06-001	N/A	N/A
Antenna	ETS	3142C	00060447	N/A	N/A



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8. TEST SUMMARY LIST

Test item	Test Requirement	Test Method	Class/Severity	Result
Conducted emission	EN IEC 55014-1	EN IEC 55014-1	EN IEC 55014-1	N/A
Radiated emission	EN IEC 55014-1	EN IEC 55014-1	EN IEC 55014-1	Pass
Harmonic current emission	EN IEC 61000-3-2	EN IEC 61000-3-2	Class A	N/A
Voltage fluctuations & flicker	EN 61000-3-3	EN 61000-3-3	§5 of EN 61000-3-3	N/A
Electrostatic discharge immunity	EN IEC 55014-2	EN 61000-4-2	± 8.0 kV (Air Discharge) ± 4.0 kV (Contact Discharge) ± 4.0 kV (Indirect Discharge)	Pass
Radiated electromagnetic field immunity	EN IEC 55014-2	EN 61000-4-3	3V/m with 80% AM. 1kHz Modulation.	Pass
Electrical fast transient/burst Immunity	EN IEC 55014-2	EN 61000-4-4	+/- 1kV for Power Supply Lines	N/A
Surge immunity	EN IEC 55014-2	EN 61000-4-5	+/- 1kV (Line to Line) +/- 2kV (Line to Ground)	N/A
Immunity to Conducted Disturbances Induced by RF fields	EN IEC 55014-2	EN 61000-4-6	3V with 80% AM. 1 kHz Modulation for Power Supply Lines	N/A
Voltage dips and short interruptions immunity	EN IEC 55014-2	EN 61000-4-11	PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees	N/A

Note: N/A means not applicable.



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9. EN IEC 55014-1 RADIATED EMISSION TEST

9.1. LIMITS OF RADIATED DISTURBANCES

AT 10M DISTANCES

Frequency (MHz)	Distance (m)	Maximum Field Strength Limit (dBuV/m Q.P.)
30-230	10	30.00
230-1000	10	37.00

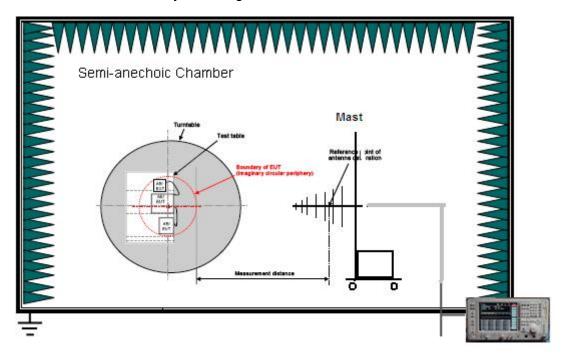
AT 3M DISTANCES

Frequency (MHz)	Distance (m)	Maximum Field Strength Limit (dBuV/m Q.P.)
30-230	3	40.00
230-1000	3	47.00

Note: The lower limit shall apply at the transition frequency.

9.2. BLOCK DIAGRAM OF TEST SETUP

System Diagram of Connections between EUT and Simulators





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9.3. PROCEDURE OF RADIATED EMISSION TEST

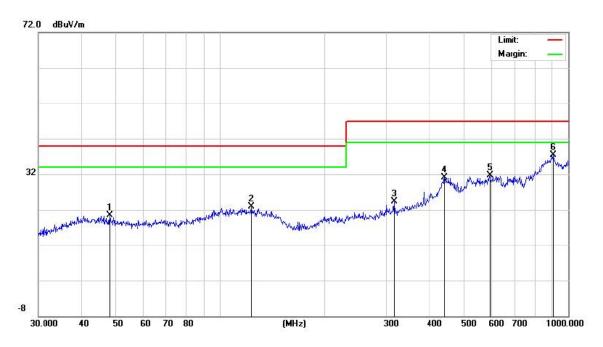
- (1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane as per EN IEC 55014-1 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 10cm non-conductive covering to insulate the EUT from the ground plane.
- (2) Support equipment, if needed, was placed as per EN IEC 55014-1.
- (3) All I/O cables were positioned to simulate typical actual usage as per EN IEC 55014-1.
- (4) The EUT works normally when powered on.
- (5) The antenna was placed at 3 meter away from the EUT as stated in EN IEC 55014-1. The antenna connected to the Analyzer via a cable and at times a pre-amplifier would be used.
- (6) The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- (7) The test mode(s) were scanned during the test.
- (8) Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and Q.P./Peak reading is presented.

Note: The recommended test voltages are 120V for the range 100V to 127V; and 230V for the range 200V to 240V; The test data of the worst case condition was reported on the Summary Data page.



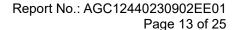
9.4. TEST RESULT OF RADIATED EMISSION TEST

Radiated Emission Test at 3m Distance-Horizontal



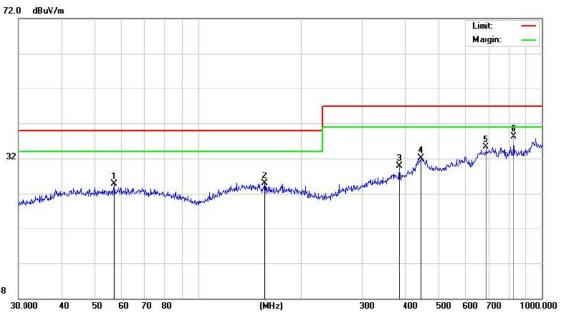
Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
	MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
	48.1626	7.15	13.33	20.48	40.00	-19.52	peak
· ·	122.8340	6.61	16.23	22.84	40.00	-17.16	peak
	315.4808	7.86	16.50	24.36	47.00	-22.64	peak
	440.1963	6.10	25.09	31.19	47.00	-15.81	peak
,	595.1329	6.75	24.91	31.66	47.00	-15.34	peak
*	903.3094	6.17	31.34	37.51	47.00	-9.49	peak
		MHz 48.1626 122.8340 315.4808 440.1963 595.1329	Mk. Freq. Level MHz dBuV 48.1626 7.15 122.8340 6.61 315.4808 7.86 440.1963 6.10 595.1329 6.75	Mk. Freq. Level Factor MHz dBuV dB 48.1626 7.15 13.33 122.8340 6.61 16.23 315.4808 7.86 16.50 440.1963 6.10 25.09 595.1329 6.75 24.91	Mk. Freq. Level Factor ment MHz dBuV dB dBuV/m 48.1626 7.15 13.33 20.48 122.8340 6.61 16.23 22.84 315.4808 7.86 16.50 24.36 440.1963 6.10 25.09 31.19 595.1329 6.75 24.91 31.66	Mk. Freq. Level Factor ment Limit MHz dBuV dB dBuV/m dB/m 48.1626 7.15 13.33 20.48 40.00 122.8340 6.61 16.23 22.84 40.00 315.4808 7.86 16.50 24.36 47.00 440.1963 6.10 25.09 31.19 47.00 595.1329 6.75 24.91 31.66 47.00	Mk. Freq. Level Factor ment Limit Over MHz dBuV dB dBuV/m dB/m dB 48.1626 7.15 13.33 20.48 40.00 -19.52 122.8340 6.61 16.23 22.84 40.00 -17.16 315.4808 7.86 16.50 24.36 47.00 -22.64 440.1963 6.10 25.09 31.19 47.00 -15.81 595.1329 6.75 24.91 31.66 47.00 -15.34

RESULT: PASS





Radiated Emission Test at 3m Distance-Vertical



No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
1		56.9912	7.64	17.07	24.71	40.00	-15.29	peak
2		155.9101	6.77	18.20	24.97	40.00	-15.03	peak
3		383.9318	8.25	21.56	29.81	47.00	-17.19	peak
4		444.8514	6.29	25.88	32.17	47.00	-14.83	peak
5		687.1507	7.39	27.84	35.23	47.00	-11.77	peak
6	*	827.4934	10.59	27.63	38.22	47.00	-8.78	peak

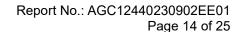
RESULT: PASS

Note:

Level(dBuV/m)=Reading(dBuV)+Factor(dB/m)

Factor(dB/m)=Antenna Factor(dB/m)+Cable loss(dB)+Attenuation(dB)for Attenuator

Over= Measurement-Limit





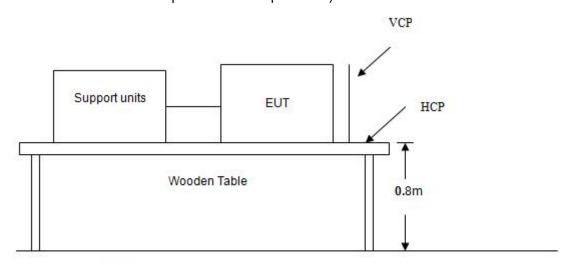
10. EN 61000-4-2 ESD IMMUNITY TEST

ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

Port	Enclosure
Basic Standard	EN 61000-4-2
Test Level	± 8.0 kV (Air Discharge) ± 4.0 kV (Contact Discharge) ± 4.0 kV (Indirect Discharge)
Standard require	В
Temperature	23°C
Humidity	47% RH

10.1. BLOCK DIAGRAM OF TEST SETUP

(The 470 k ohm resistors are installed per standard requirement)



Ground Reference Plane₽



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10.2. TEST PROCEDURE

The EUT was located 0.1 m minimum from all side of the HCP.

The support units were located 1 m minimum away from the EUT.

EUT worked with resistance load, and make sure EUT worked normally.

Actives the communication function if the EUT with such port(s).

As per the requirement of EN IEC 55014-2: Contact discharge is the preferred test method. 20 discharges (10 with positive and 10 negative polarity) shall be applied on each accessible metal part of the enclosure. In case of a non-conductive enclosure, discharges shall be applied on the horizontal or vertical coupling planes as specified in EN 61000-4-2.

Air discharges shall be used where contact discharges cannot be applied.

The following test condition was followed during the tests.

Note: As per the A2 to EN 61000-4-2, a bleed resistor cable is connected between the EUT and HCP during the test.

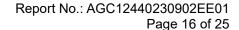
The electrostatic discharges were applied as follows:

Amount of Discharges	Voltage	Coupling	Result
Mini 20 /Point	±4kV	Contact Discharge	Α
Mini 20 /Point	±4kV	Indirect Discharge HCP (Front)	Α
Mini 20 /Point	±4kV	Indirect Discharge HCP (Back)	Α
Mini 20 /Point	±4kV	Indirect Discharge HCP (Left)	Α
Mini 20 /Point	±4kV	Indirect Discharge HCP (Right)	Α
Mini 20 /Point	±4kV	Indirect Discharge VCP (Front)	Α
Mini 20 /Point	±4kV	Indirect Discharge VCP (Back)	Α
Mini 20 /Point	±4kV	Indirect Discharge VCP (Left)	Α
Mini 20 /Point	±4kV	Indirect Discharge VCP (Right)	Α
Mini 20 /Point	±8kV	Air Discharge	Α

10.3. PERFORMANCE & RESULT

Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

⊠ PASS	□ EAU	
△ PA33	□ FAIL	



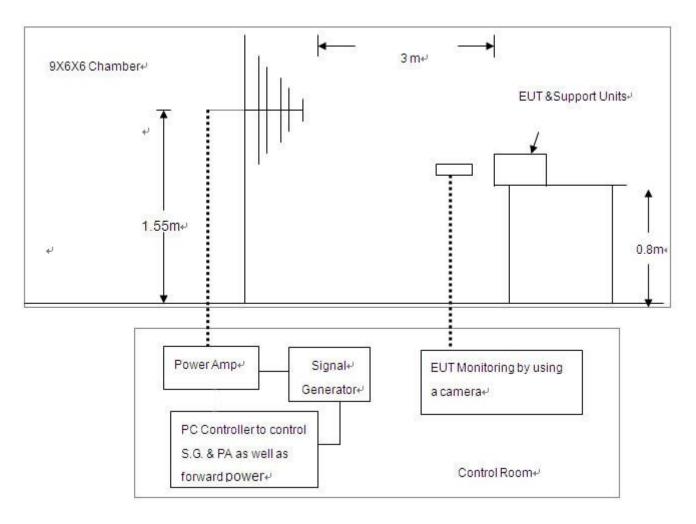


11. EN 61000-4-3 RS IMMUNITY TEST

RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port	Enclosure		
Basic Standard	EN 61000-4-3		
Test Level:	BV/m with 80% AM. 1kHz Modulation.		
Standard require	Α		
Temperature	23.7°C		
Humidity	61.2% RH		

11.1. BLOCK DIAGRAM OF TEST SETUP





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11.2. TEST PROCEDURE

The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per EN 61000-4-3.

EUT worked with resistance load, and make sure EUT worked normally.

Setting the testing parameters of RS test software per EN 61000-4-3.

Performing the test at each side of with specified level (3V/m) at 1% steps and test frequency from 80MHz to 1000MHz.

Recording the test result in following table.

EN 61000-4-3 Final test conditions:

Test level: 3V/m

Steps: 1 % of fundamental

Dwell Time: 1 sec

Range (MHz)	Field	Modulation	Polarity	Position	Test Performance	Result
80-1000	3V/m	AM	Н	Front	No function loss	Α
80-1000	3V/m	AM	Н	Left	No function loss	Α
80-1000	3V/m	AM	Н	Back	No function loss	А
80-1000	3V/m	AM	Н	Right	No function loss	А
80-1000	3V/m	AM	V	Front	No function loss	А
80-1000	3V/m	AM	V	Left	No function loss	А
80-1000	3V/m	AM	V	Back	No function loss	А
80-1000	3V/m	AM	V	Right	No function loss	Α



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11.3. PERFORMANCE & RESULT

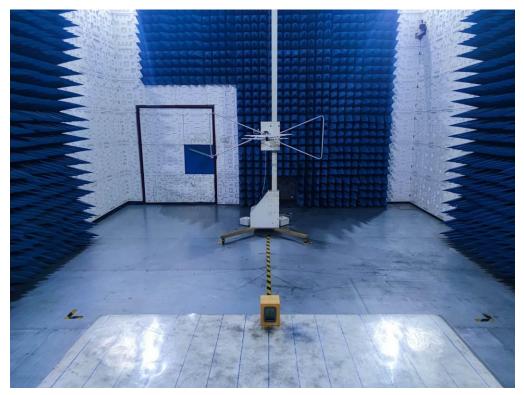
Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

⊠ PASS	□ FAIL	
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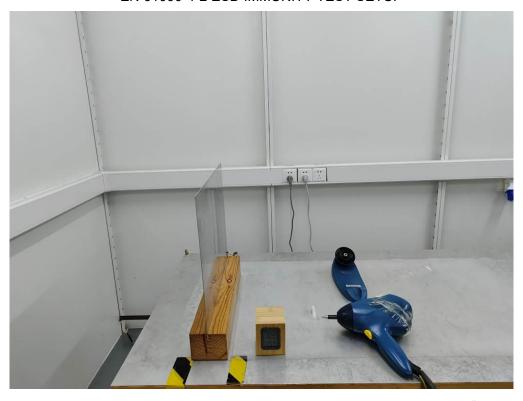


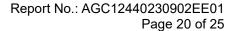
APPENDIX A: PHOTOGRAPHS OF TEST SETUP

EN IEC 55014-1 RADIATED EMISSION TEST SETUP



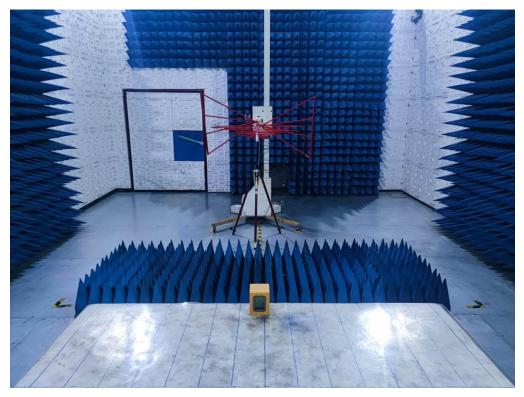
EN 61000-4-2 ESD IMMUNITY TEST SETUP

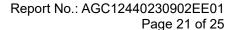








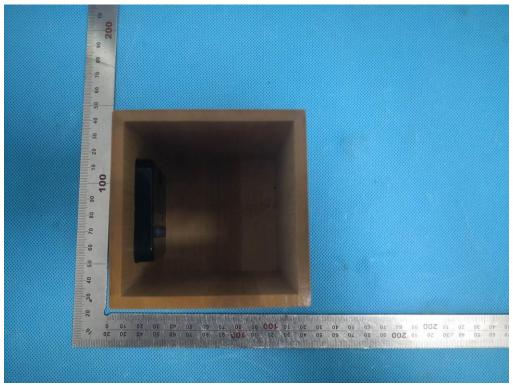






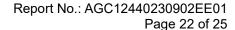
APPENDIX B: PHOTOGRAPHS OF EUT

TOP VIEW OF EUT



BOTTOM VIEW OF EUT





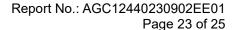


FRONT VIEW OF EUT



BACK VIEW OF EUT





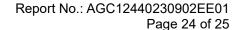


LEFT VIEW OF EUT



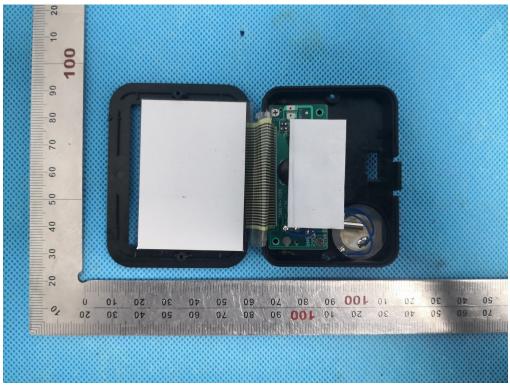
RIGHT VIEW OF EUT



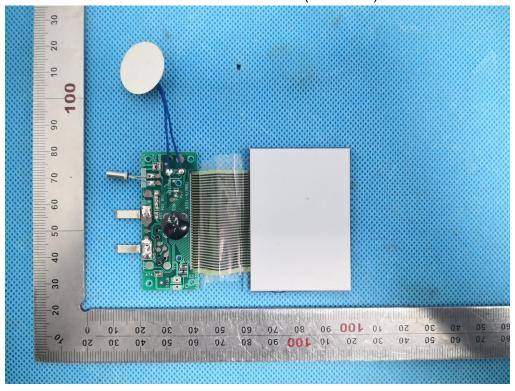


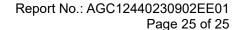


OPEN VIEW OF EUT (FIGURE 1)



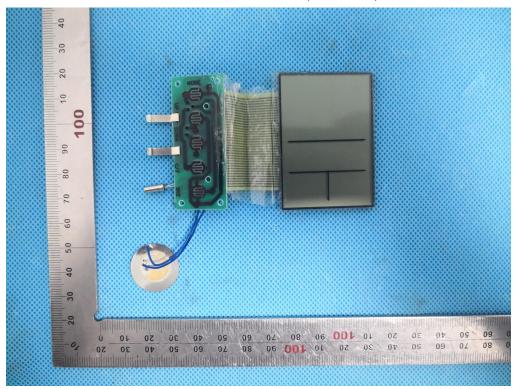
INTERNAL VIEW OF EUT (FIGURE 1)



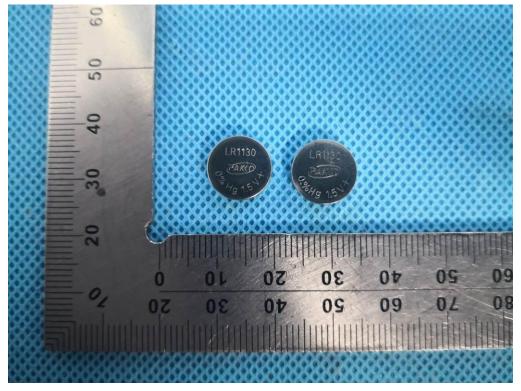




INTERNAL VIEW OF EUT (FIGURE 2)



BATTERY VIEW OF EUT



----END OF REPORT----

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Tel: +86-755 2523 4088 E-mail: agc@agccert.com Web: http://www.agccert.com/



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